

FORM HDP-1449 (Based on Form PTO-1449)

PATENT AND TRADEMARK OFFICE

(Use several sheets if necessary)

Sheet 1 of 2

ATTORNEY DOCKET NO.	APPLICATION No.
1740-000046/US	10/849,050
APPLICANT	
Jin Yong KIM et al.	
FILING DATE	GROUP
May 20, 2004	2627

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Examiner:	Date Considered:	

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PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE CITATION

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Sheet 2 of 2

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Examiner:	Date Considered: